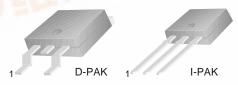


### **MJD112**

### **D-PAK for Surface Mount Applications**

- High DC Current Gain
- Built-in a Damper Diode at E-C
- Lead Formed for Surface Mount Applications (No Suffix)
- Straight Lead (I-PAK, " I " Suffix)
- Electrically Similar to Popular TIP112

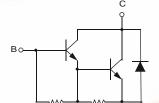


1.Base 2.Collector 3.Emitter

### **NPN Silicon Darlington Transistor**

### Absolute Maximum Ratings T<sub>C</sub>=25°C unless otherwise noted

Symbol	Parameter	Value	Units
V <sub>CBO</sub>	Collector-Base Voltage	100	V
V <sub>CEO</sub>	Collector-Emitter Voltage	100	V
V <sub>EBO</sub>	Emitter-Base Voltage	5	V
Ic	Collector Current (DC)	2	А
I <sub>CP</sub>	Collector Current (Pulse)	4	Α
I <sub>B</sub>	Base Current	50	mA
P <sub>C</sub>	Collector Dissipation (T <sub>C</sub> =25°C)	20	W
	Collector Dissipation (T <sub>a</sub> =25°C)	1.75	W
T <sub>J</sub>	Junction Temperature	150	°C
T <sub>STG</sub>	Storage Temperature	- 65 ~ 150	°C



Equivalent Circuit

 $R1 \cong 10 k\Omega$  E  $R2 \cong 0.6 k\Omega$ 

## Electrical Characteristics $T_C=25$ °C unless otherwise noted

Symbol	Parameter	Test Condition	Min.	Max.	Units
V <sub>CEO</sub> (sus)	Collector-Emitter Sustaining Voltage	$I_C = 30 \text{mA}, I_B = 0$	100		V
I <sub>CEO</sub>	Collector Cut-off Current	$V_{CE} = 50V, I_{B} = 0$		20	μΑ
I <sub>CBO</sub>	Collector Cut-off Current	$V_{CB} = 100V, I_B = 0$		20	μΑ
I <sub>EBO</sub>	Emitter Cut-off Current	$V_{EB} = 5V, I_{C} = 0$		2	mA
h <sub>FE</sub>	* DC Current Gain	$V_{CE} = 3V, I_{C} = 0.5A$ $V_{CE} = 3V, I_{C} = 2A$ $V_{CE} = 3V, I_{C} = 4A$	500 1000 200	12K	C.CO
V <sub>CE</sub> (sat)	* Collector-Emitter Saturation Voltage	$I_C = 2A, I_B = 8mA$ $I_C = 4A, I_B = 40mA$	MANA	2 3	V
V <sub>BE</sub> (sat)	* Base-Emitter Saturation Voltage	I <sub>C</sub> = 4A, I <sub>B</sub> = 40mA		4	V
V <sub>BE</sub> (on)	* Base-Emitter ON Voltage	$V_{CE} = 3A, I_{C} = 2A$		2.8	V
f <sub>T</sub>	Current Gain Bandwidth Product	$V_{CE} = 10V, I_{C} = 0.75A$	25		MHz
C <sub>ob</sub>	Output Capacitance	$V_{CB} = 10V, I_{E} = 0$ f = 0.1MHz		100	pF

\* Pulse Test: PW≤300μs, Duty Cycle≤2%

## **Typical Characteristics**

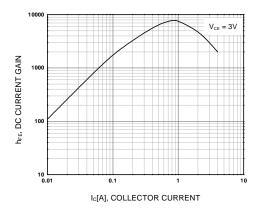


Figure 1. DC current Gain

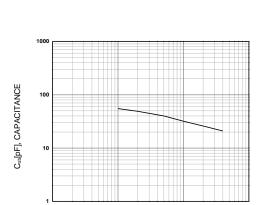


Figure 3. Collector Output Capacitance

 $V_{\text{CB}}[V]$ , COLLECTOR-BASE VOLTAGE

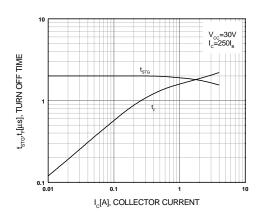


Figure 5. Turn Off Time

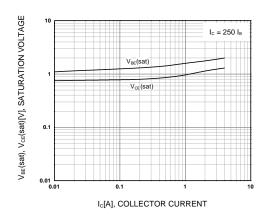


Figure 2. Base-Emitter Saturation Voltage Collector-Emitter Saturation Voltage

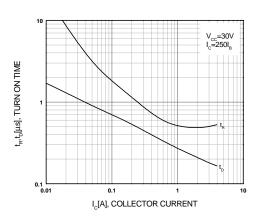


Figure 4. Turn On Time

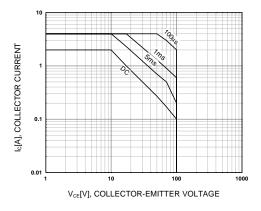


Figure 6. Safe Operating Area

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# Typical Characteristics (Continued)

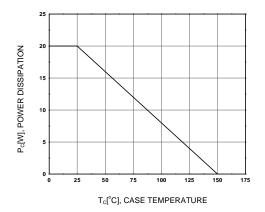
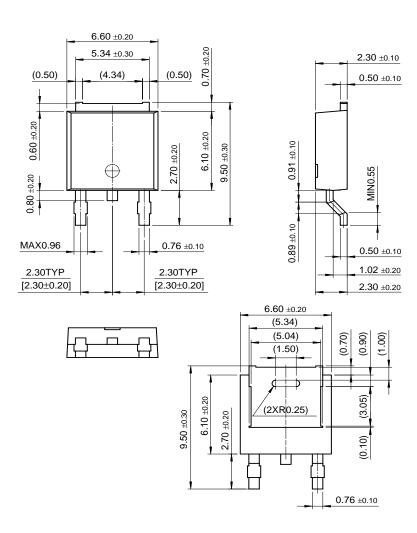


Figure 7. Power Derating

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## **Package Demensions**

## D-PAK



Dimensions in Millimeters

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